

Notice of References Cited	Application/Control No. 10/672,204		Applicant(s)/Patent Under Reexamination BEJERANO ET AL.	
	Examiner Philip Guyton		Art Unit 2113	Page 1 of 1

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*	B	US-6,363,056	03-2002	Beigi et al.	370/252
*	C	US-2004/0230680	11-2004	Jain et al.	709/226
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*	E	US-2006/0239199	10-2006	Blair et al.	370/248
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NON-PATENT DOCUMENTS

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	V	Brodie et al. "Intelligent Probing: a Cost-Effective Approach to Fault Diagnosis in Computer Networks." IBM Systems Journal, Vol. 41, No. 3, 2002.			
	W	Bejerano et al. "Robust Monitoring of Link Delays and Faults in IP Networks." 22nd Annual Joint Conf. of IEEE Computer and Communications Societies, 30 March-3 April 2003.			
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.